

<b>Searched</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09769451	WAKAI ET AL.
	Examiner Nguyen, Jennifer T	Art Unit 2629

Class	SubClass	Date	Examiner
345	157,158,173-178	8/16/06	JN

U.S. Patent and Trademark Office	Part of Paper No.:
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<b>Interference Searched</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
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Class	SubClass	Date	Examiner
718	18.01-18.03, 19	8/16/06	JN

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<b>Search Notes</b>  	Application/Control No.	Applicant(s)/Patent Under Reexamination
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Notes	Date	Examiner
East search, PAJ search, claim interference search	8/16/06	JN
U.S. Patent and Trademark Office		Part of Paper No.: